## Notice of References Cited

Application/Control No. 10/089,425	Applicant(s)/Patent Under Reexamination EDER, STEFAN		
Examiner	Art Unit		
Bao O. Vu	2838	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,225,676 B1	05-2001	Hattori et al.	257/516
	В	US-3,980,881 A	09-1976	Veach et al.	250/261
	С	US-4,763,237 A	08-1988	Wieczorek, John P.	363/20
	D	US-4,814,712 A	03-1989	Burton et al.	324/424
	Ε	US-4,881,023 A	11-1989	Perusse et al.	323/266
	F	US-5,132,893 A	07-1992	Klein et al.	363/49
	G	US-5,168,436 A	12-1992	Barlage, Francis M.	363/21.17
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	ø					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	C	
	<b>&gt;</b>	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.